

<b>Notice of References Cited</b>	Application/Control No. 10/510,452	Applicant(s)/Patent Under Reexamination ERIKSSON ET AL.	
	Examiner Hanh Nguyen	Art Unit 2416	Page 1 of 1

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*	C	US-7,447,181	11-2008	Forssell, Mika	370/336
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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